Notice of References Cited Application/Control No. 10/806,030 Applicant(s)/Patent Under Reexamination HIGUCHI ET AL. Examiner Rene Garcia, Jr. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

* .		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0128232	06-2005	Shinkawa, Osamu	347/010
*	В	US-6,299,277	10-2001	Fujii, Hiroyuki	347/23
*	С	US-5,475,404	12-1995	Takahashi et al.	347/23
*	D	US-6,820,955	11-2004	Usui, Toshiki	347/7
*	Ε	US-2004/0056915	03-2004	Miyazawa, Takashi	347/019
*	F	US-2002/0018090	02-2002	Takazawa et al.	347/19
*	G	US-2004/0252144	12-2004	Higuchi et al.	347/005
*	H	US-2002/0170353	11-2002	Usui et al.	73/290.00V
*	1	US-2002/0039120	04-2002	Otsuka et al.	347/29
*	J	US-4,577,203	03-1986	Kawamura, Yoshikazu	347/30
*	к	US-5,379,061	01-1995	Yamaguchi et al.	347/23
*	L	US-6,257,694	07-2001	Tokumaru et al.	347/19
*	М	US-2002/0105555	08-2002	Tsukada et al.	347/7

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	: : :
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	x		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.